



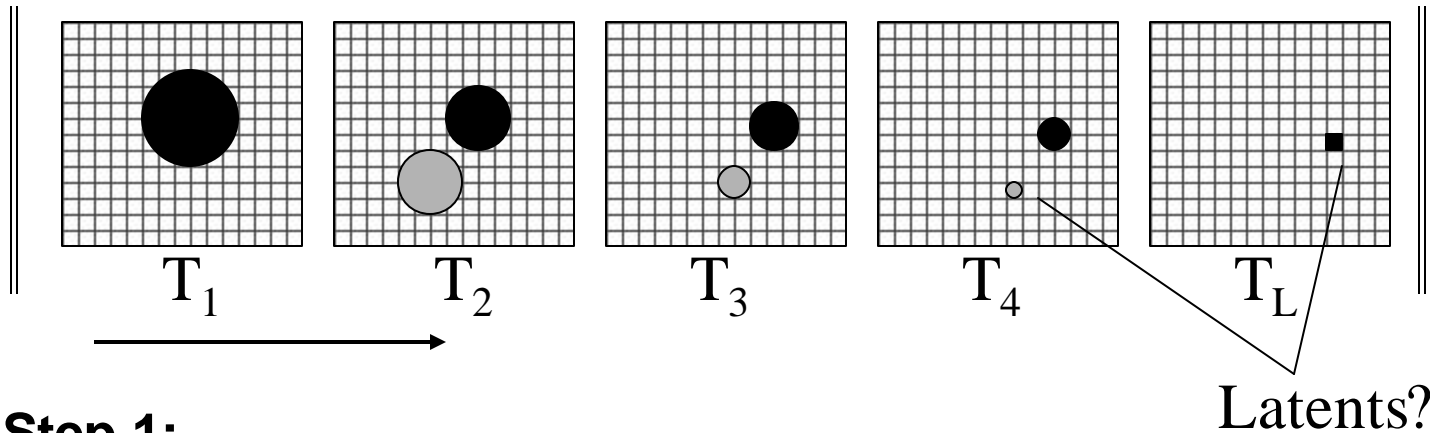
Latent-Image Flagging

Frank Masci

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- **AIM**: To self-consistently flag pixels containing a latent by predicting forward in time which pixel intensities in an ensemble of images are likely to persist as latents in subsequent images of the ensemble.
- Will be performed at the post BCD level and comprise a BQD product.
- Main products:
 - ⊙ Each BCD will have an accompanying 8-bit FITS image (called an L-mask) which specifies latent pixels with the value “1” and “0” if not.
 - ⊙ For storage limitations, L-mask is only produced if latents are found.
 - ⊙ A table which reports latent-pixel locations.
- Will involve ensemble processing of BCDs within a **single AOR**. There will be no crossing of AOR boundaries.



Step 1:

- From a latent decay model, compute the pixel threshold intensity (or total count) DN_{thres}_i in each image i of the AOR ensemble which will produce a latent above some noise level in all subsequent images.
- The predicted latent intensity has following functional dependence:

$$DN_{pred}(L)_i = f(T_L, DN_i, \Delta T_{Li}),$$

- T_L = Total time between resets in latent-reporting image (i.e. "frame time"). This determines the number of (latent) charge traps released.



Algorithm continued..

- DN_i = Total count within exposure time of the initial illumination frame i (or “fluence”).
- ΔT_{Li} = Time elapsed since the start of the latent reporting image L and the end of illumination period in frame i - i.e. the latent decay time.
- From above model, we want to determine the threshold DN_i (DN_{thres_i}) above which a latent will persist above some factor of the noise xS_L in image L :
$$xS_L = f(T_L, DN_{thres_i}, \Delta T_{Li}),$$
- In the above example, each initial illumination frame will have a list of thresholds corresponding to each subsequent “latent-reporting” image:

Img 1: $DN_{thres_1}(T_2, xS_2, \Delta T_{2-1}), DN_{thres_1}(T_3, xS_3, \Delta T_{3-1}), DN_{thres_1}(T_4, xS_4, \Delta T_{4-1}) \dots$

Img 2: $DN_{thres_2}(T_3, xS_3, \Delta T_{3-2}), DN_{thres_2}(T_4, xS_4, \Delta T_{4-2}), DN_{thres_2}(T_5, xS_5, \Delta T_{5-2}) \dots$

⋮



Step 2:

- Flag all “suspected” latent pixels in each image of the ensemble by flagging those pixels in the preceding illumination images that have a total count (fluence) above the corresponding predicted thresholds.
- In the above example, suppose we desire a latent image report for image number 4 in the ensemble. This will be accomplished by flagging all pixels in images 1 -- 3 which have a total count:

$$DN > DNthres_1(T_4, xS_4, \Delta T_{4-1}).$$

&

$$DN > DNthres_2(T_4, xS_4, \Delta T_{4-2}).$$

&

$$DN > DNthres_3(T_4, xS_4, \Delta T_{4-3}).$$



- Require a model in terms of a look-up table which shows the dependence of latent fluence (in electrons) on:
 - The initial source intensity (fluence) at $t = 0$ for a fixed exposure time (T_EXP). This can be later re-scaled for arbitrary T_EXP .
 - Time since the illumination was turned off.
 - Latent image frame time. (Duration in which the resulting latent fluence was measured).
- Pixel dependent noise model in the form of a look-up table, otherwise a single noise value will be computed from the distribution of background pixel counts.